

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10573328	MAEKAWA, SHINJI
	<b>Examiner</b>	<b>Art Unit</b>
	ANTHONY HO	2815

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	40, 59, 72	11/21/2008	AH
438	99, 149	11/21/2008	AH

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consult Primary Examiner Jerome Jackson	11/21/2008	AH
EAST Search	11/21/2008	AH
Consult related PCT and corresponding Chinese applications	11/21/2008	AH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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